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Publication date: 2016

Document Version Publisher's PDF, also known as Version of record

Link back to DTU Orbit

*Citation (APA):* Kücükyildiz, Ö. C., Jensen, S. H. N., & De Chiffre, L. (2016). Contact area measurements on structured surfaces. Poster session presented at Euspen's S.I.G. Meeting, Copenhagen, Denmark.

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# **Contact area measurements**

# on structured surfaces

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In connection with the use of brass specimens featuring structured surfaces in a tribology test, an algorithm was developed for automatic measurement of the contact area by optical means.

The contact area of the specimen after



euspen's S.I.G. Meeting: **Structured & Freeform Surfaces** 9-10 November 2016 Copenhagen, DK

deformation is visible on a digital photograph as 10 parallel bands in adequate contrast to the background.



An approach was developed that automatically performs a pixel segmentation based on local image gradient extrema, leading to an accurate band-edge segmentation. For each band, a finegrained line width is estimated through the distance transform in conjunction with non-max suppression, which can be used to estimate the desired area statistics.

During this study, the traceability of the method was established through an optical standard from NPL. Measuring line-widths in the range 10-100  $\mu$ m, errors less than 0.4 $\mu$ m were obtained.



The measurement uncertainty for a single band is calculated as

$$U = k \cdot \sqrt{u^2_{ref} + u^2_{rep} + u^2_p + u^2_e}$$
 where

The method was applied to quantify the single bands' width and it was observed on the specific item that the bands are slightly wider at the edges, indicating a higher deformation.

 $u_{ref}$  : reference uncertainty

- $u_{rep}$  : uncertainty from repeatability of the measurements on the reference  $u_{p}$  : specimen line-width uncertainty
- $u_{e}$ : uncertainty coming from the coefficient of thermal expansion

A general expanded uncertainty (k=2) of 0.5 $\mu$ m was estimated for single band measurement on the brass specimen.

Based on the study, it is concluded that the method for automatic measurement of contact areas provides traceable measurements for the investigated dimensional range.

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